Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

Listing of Claims

1-11. (Cancelled)

12. (Currently amended). An arrangement for contacting terminals of a substrate comprising a substrate surface, a first terminal surface, and a second terminal having a second terminal surface, the first terminal surface being located at a shorter distance from the substrate surface than the second terminal surface, the arrangement comprising:

a first insulating layer on the substrate surface, having an insulation-layer surface being located at a longer distance from the substrate surface than the second terminal surface, wherein a part of said first insulating layer is arranged between the first and the second terminal;

a second insulating layer arranged on the first insulating layer;

wherein the fist insulating layer has a contact via which extends from the insulation-layer surface to the first terminal surface and is filled with a first conductive material, and wherein the second insulating layer has a <u>first</u> recess, said <u>first</u> recess penetrating the second insulating layer and extending to the first conductive material and into the first <u>insulating</u> dielectric layer and being filled with a second conductive material, such that the second conductive material contacts the first conductive material on a top surface and on a portion of a side surface thereof; and

wherein a <u>second</u> recess extends to the second terminal surface through the first and second insulating layers, and is filled with a third conductive material.

13. (Previously presented). The arrangement as claimed in claim 12, wherein the first terminal is one of a base terminal and a collector terminal, and the second terminal is an emitter terminal, arranged on a stack, of a bipolar transistor.

- 14. (Previously presented). The arrangement as claimed in claim 12, wherein the first terminal is one of a source terminal and a drain terminal, and the second terminal is a gate terminal of a field-effect transistor.
- 15. (Previously presented). The arrangement as claimed in claim 12, wherein the first terminal is formed on the substrate and is selected from the group of a base terminal of a bipolar transistor, a collector terminal of a bipolar transistor, a gate terminal of a field-effect transistor, a source terminal of a field-effect transistor and a drain terminal of a field-effect transistor.
- 16. (Previously presented). The arrangement as claimed in claim 12, wherein at least one of the first conductive material, the second conductive material and the third conductive material comprises metal.
- 17. (Original). The arrangement as claimed in claim 12, wherein the first conductive material is tungsten.
- 18. (Previously presented). The arrangement as claimed in claim 12, wherein at least one of the second and third conductive materials is copper.
- 19. (Original). The arrangement as claimed in claim 12, wherein the second conductive material is conductively connected to the first conductive material and forms a first contact terminal, and wherein the third conductive material is conductively connected to the second terminal and forms a second contact terminal.
- 20. (Original). The arrangement as claimed in claim 12, wherein the first and second contact terminals form a wiring plane.